

## Single P-Channel MOSFET

### ■ DESCRIPTION

STP4435 is the P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior ,fast switching performance, and withstand high energy pulse in the avalanche and commutation mode. This device is suitable for use as a load switch or PWM applications.

### ■ PART NUMBER INFORMATION

**STP 4435 M - TR G**

a	b	c	d	e
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a : Company name.

b : Product Serial number.

c : Package code M:SOP-8

d : Handling code TR:Tape&Reel

e : Green produce code G:*RoHS Compliant*

### ■ FEATURES

**$V_{DS} = -30V, I_D = -10.6A$**

$R_{DS(ON)}=14m\Omega(Typ.)@V_{GS}=-10V$

$R_{DS(ON)}=18m\Omega(Typ.)@V_{GS}=-4.5V$

◆Fast switch

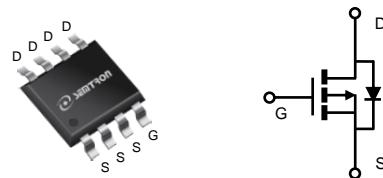
◆High power and current handling capability

### ■ APPLICATIONS

◆Load Switch

◆LED Application

◆DC-DC Power Management



SOP-8

### ■ ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ C$ Unless otherwise noted )

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-Source Voltage	-30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current	$T_A=25^\circ C$ $T_A=70^\circ C$	-10.6 -8.5
$I_{DM}$	Pulsed Drain Current <sup>A</sup>	-42.4	A
$I_{AS}$	Avalanche Current <sup>A</sup>	-30	A
$E_{AS}$	Single Pulse Avalanche energy L=0.1mH <sup>AE</sup>	45	mJ
$P_D$	Power Dissipation <sup>B</sup>	$T_A=25^\circ C$ $T_A=70^\circ C$	3.1 2
$T_J$	Operation Junction Temperature	-55/150	°C
$T_{STG}$	Storage Temperature Range	-55/150	°C

### ■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>B</sup>	$t \leq 10s$	40	°C/W
	Thermal Resistance Junction to Ambient <sup>BC</sup>	Steady-State	70	

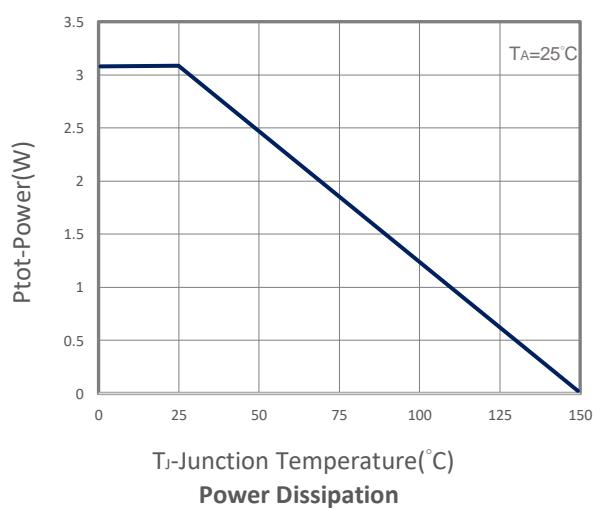
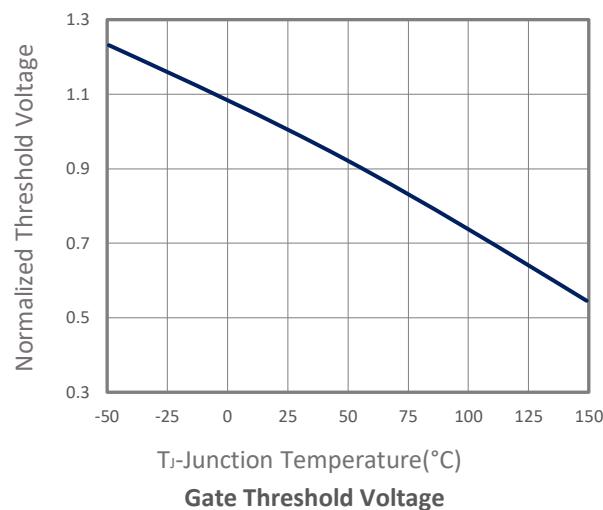
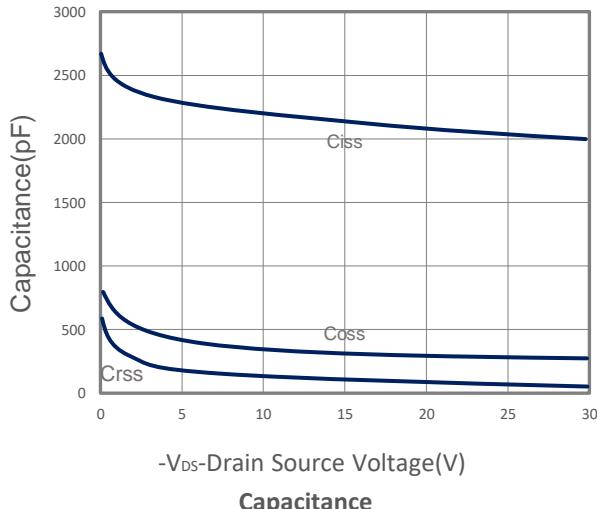
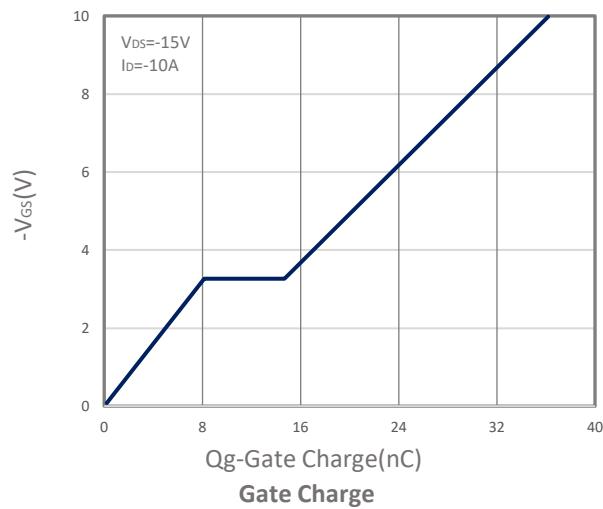
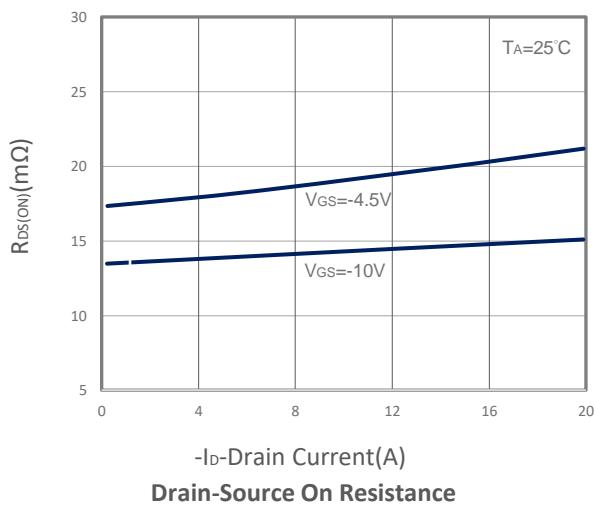
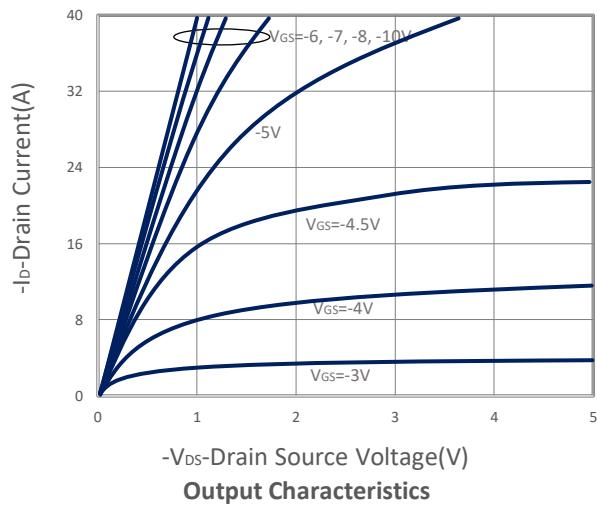
**ELECTRICAL CHARACTERISTICS( $T_A = 25^\circ\text{C}$  Unless otherwise noted)**

Symbol	Parameter	Condition	Min	Typ	Max	Unit	
<b>Static Parameters</b>							
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=-250\mu\text{A}$	-30			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1	-1.6	-2.5	V	
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			$\pm 100$	nA	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-30\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$		-1		$\mu\text{A}$	
		$V_{DS}=-24\text{V}, V_{GS}=0\text{V}, T_J=75^\circ\text{C}$		-10			
$R_{DS(\text{ON})}$	Drain-source On-Resistance <sup>D</sup>	$V_{GS}=-10\text{V}, I_D=-10.6\text{A}$		14	18	$\text{m}\Omega$	
		$V_{GS}=-4.5\text{V}, I_D=-8\text{A}$		18	25		
$G_f$	Forward Transconductance	$V_{DS}=-10\text{V}, I_D=-10\text{A}$		12.5		S	
<b>Diode Characteristics</b>							
$V_{SD}$	Diode Forward Voltage <sup>D</sup>	$I_S=-1\text{A}, V_{GS}=0\text{V}$		-0.7	-1	V	
$I_S$	Continuous Source Current				-10.6	A	
$t_{rr}$	Reverse Recovery Time	$I_S=-10\text{A}, dI/dt=100\text{A}/\mu\text{s}$		13.8		ns	
$Q_{rr}$	Reverse Recovery Charge			12.3		nC	
<b>Dynamic and Switching Parameters</b>							
$Q_g$	Total Gate Charge	$V_{DS}=-15\text{V}, V_{GS}=-10\text{V}$ $I_D=-10\text{A}$		36	48.6	nC	
$Q_g$	Total Gate Charge (4.5V)			18	24.3		
$Q_{gs}$	Gate-Source Charge			8.1	10.9		
$Q_{gd}$	Gate-Drain Charge			6.8	9.2		
$C_{iss}$	Input Capacitance	$V_{DS}=-15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		2150		pF	
$C_{oss}$	Output Capacitance			298			
$C_{rss}$	Reverse Transfer Capacitance			135			
$R_g$	Gate Resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		8.8		$\Omega$	
$t_{d(on)}$	Turn-On Time <sup>D</sup>	$V_{DD}=-15\text{V}, V_{GEN}=-10\text{V},$ $R_G=3.3\Omega, I_D=-1\text{A}$		7.7	15	nS	
				57.8	129		
$t_{d(off)}$	Turn-Off Time <sup>D</sup>			57.5	109		
				21.3	40		

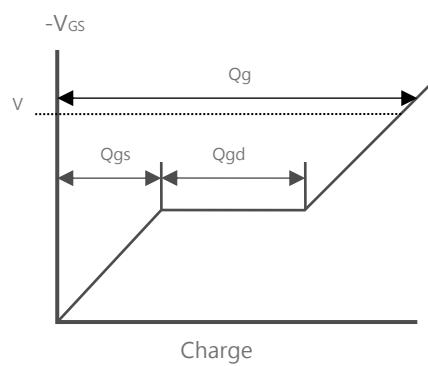
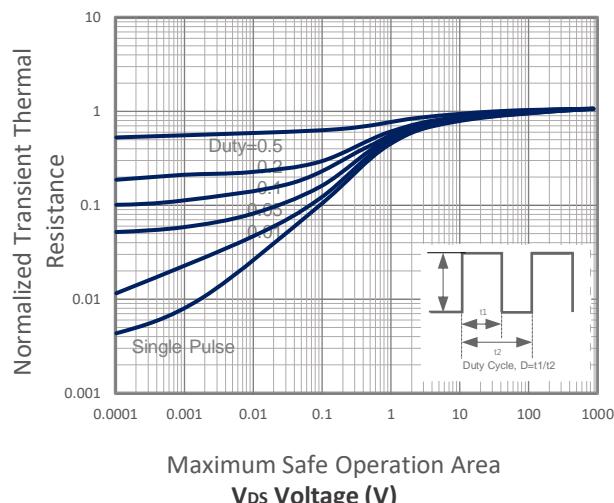
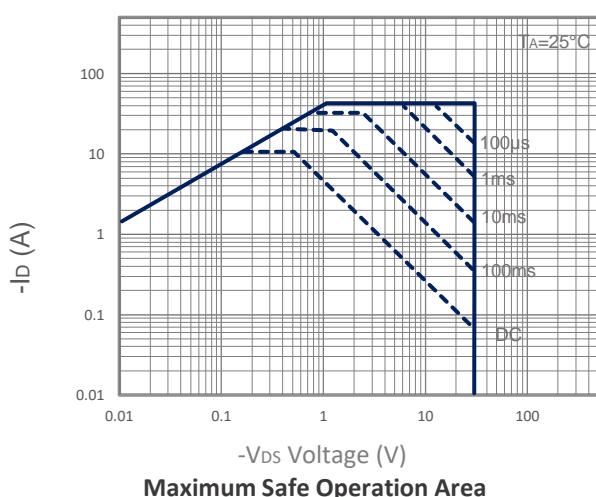
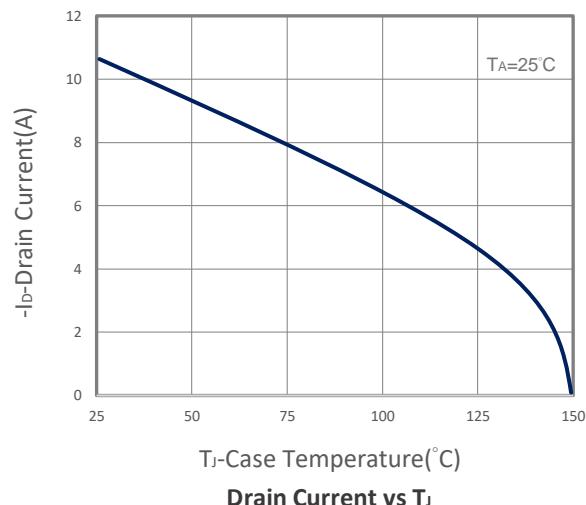
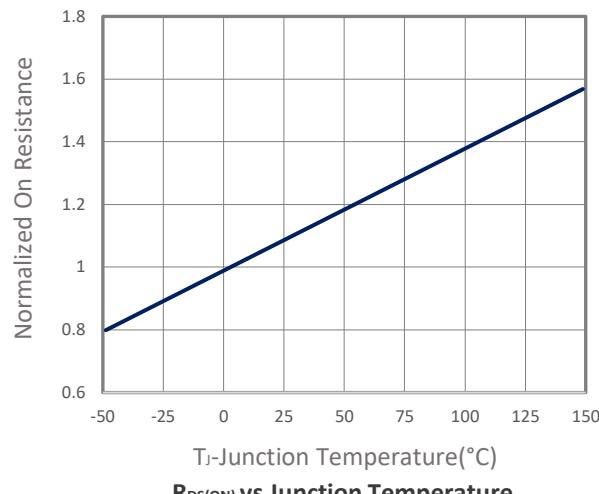
Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

- A. Pulsed width limited by maximum junction temperature,  $T_J(\text{MAX})=150^\circ\text{C}$ .
- B. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in2 FR-4 board in a still air environment with maximum junction temperature  $T_J(\text{MAX})=150^\circ\text{C}$  (initial temperature  $T_A=25^\circ\text{C}$ ).
- C.  $T_J(\text{MAX})=150^\circ\text{C}$ , using junction-to-case thermal resistance ( $R_{\theta JC}$ ) is more useful in additional heat sinking is used.
- D. The data tested by pulsed, pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- E. The EAs data shows Max, tested and pulse width limited by  $T_J(\text{MAX})=150^\circ\text{C}$  (initial temperature  $T_J=25^\circ\text{C}$ ).

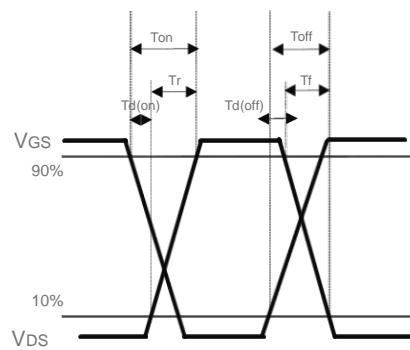
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**TYPICAL CHARACTERISTICS**


## TYPICAL CHARACTERISTICS

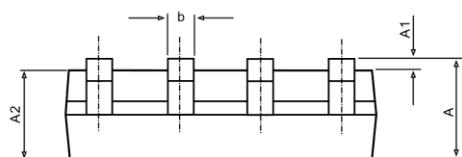
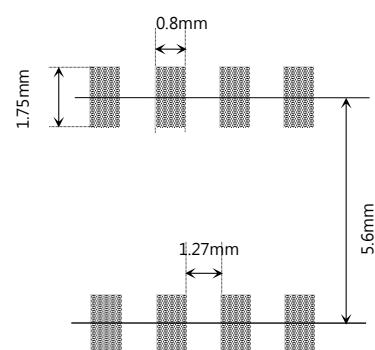
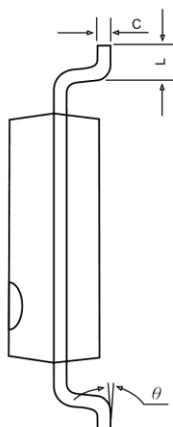
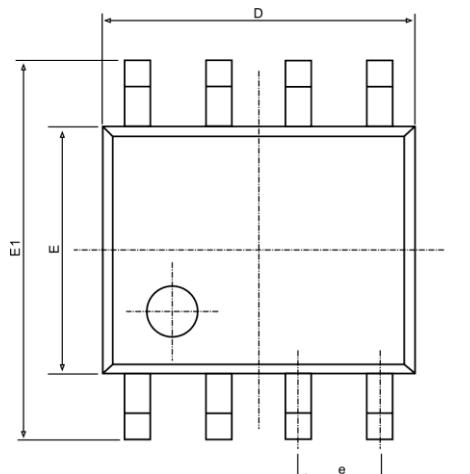


Gate Charge Waveform



Switching Time Waveform

## SOP-8 PACKAGE DIMENSIONS



Recommended Land Pattern

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.040	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.130	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270BSC.		0.050BSC.	
L	0.400	1.270	0.016	0.005
$\Theta$	0°	8°	0°	8°